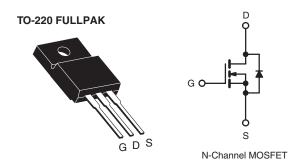


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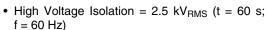
Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	200			
$R_{DS(on)}(\Omega)$	V _{GS} = 5.0 V	0.40		
Q _g (Max.) (nC)	40			
Q _{gs} (nC)	5.5			
Q _{gd} (nC)	24			
Configuration	Single			



FEATURES







COMPLIANT

- Sink to Lead Creepage Distance = 4.8 mm
- · Logic-Level Gate Drive
- R_{DS(on)} Specified at V_{GS} = 4 V and 5V
- · Fast Switching
- · Ease of paralleling
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION				
Package	TO-220 FULLPAK			
Lead (Pb)-free	IRLI630GPbF			
	SiHLI630G-E3			
SnPb	IRLI630G			
	SiHLI630G			

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	200	V	
Gate-Source Voltage			V_{GS}	± 10	V	
Continuous Drain Current	V _{GS} at 5.0 V	$T_C = 25 \degree C$ $T_C = 100 \degree C$	I _D	6.2	А	
				3.9		
Pulsed Drain Current ^a			I _{DM}	25		
Linear Derating Factor				0.28	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	125	mJ	
Repetitive Avalanche Current ^a			I _{AR}	6.2	Α	
Repetitive Avalanche Energy ^a			E _{AR}	3.5	mJ	
Maximum Power Dissipation	T _C = 25 °C		P_{D}	35	W	
Peak Diode Recovery dV/dt ^c			dV/dt	5.0	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)	for '	10 s		300 ^d		
Mounting Torque	6 22 or N	6-32 or M3 screw		10	lbf ⋅ in	
	0-32 OF IVIS SCIEW			1.1	N · m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD}=25$ V, starting $T_J=25$ °C, L = 2.4 mH, $R_G=25$ Ω , $I_{AS}=6.2$ A (see fig. 12). c. $I_{SD}\leq 9.0$ A, dl/dt ≤ 120 A/ μ s, $V_{DD}\leq V_{DS}$, $T_J\leq 150$ °C. d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRLI630G, SiHLI630G

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	3.6	C/VV	

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT		
Static								
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	200	-	-	V		
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = 1 mA		-	0.27	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	$V_{DS} = V_{GS}, I_D = 250 \mu A$		-	2.0	V	
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 10 V		-	± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =	V _{DS} = 200 V, V _{GS} = 0 V		-	25		
		V _{DS} = 160 V	', V _{GS} = 0 V, T _J = 125 °C	-	-	250	μΑ	
Drain-Source On-State Resistance	_	V _{GS} = 5.0 V	I _D = 3.7 A ^b	-	-	0.40	<u> </u>	
	$R_{DS(on)}$	V _{GS} =4.0 V	I _D = 3.1 A ^b	-	-	0.50	Ω	
Forward Transconductance	9 _{fs}	V _{DS} = 50 V, I _D = 5.4 A ^b		4.8	-	-	S	
Dynamic		•						
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1.0 \text{ MHz, see fig. 5}$		-	1100	-	pF	
Output Capacitance	C _{oss}			-	220	-		
Reverse Transfer Capacitance	C _{rss}			-	70	-		
Total Gate Charge	Qg			-	-	40		
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$V_{GS} = 10 \text{ V}$ $I_D = 9.0 \text{ A}, V_{DS} = 160 \text{ V},$ see fig. 6 and 13 ^b		-	5.5	nC	
Gate-Drain Charge	Q _{gd}				-	24		
Turn-On Delay Time	t _{d(on)}		1		8.0	-	- ns	
Rise Time	t _r	$V_{DD} = 100 \text{ V}, I_D = 9.0 \text{ A},$ $R_G = 6.0 \Omega, R_D = 11\Omega,$ see fig. 10^b		-	57	-		
Turn-Off Delay Time	t _{d(off)}			-	38	-		
Fall Time	t _f			-	33	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	- nH	
Internal Source Inductance	L _S			-	7.5	-		
Drain-Source Body Diode Characteristic	s						,	
Continuous Source-Drain Diode Current	I _S	MOSFET sym	MOSFET symbol showing the		-	6.2	- A	
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	25		
Body Diode Voltage	V_{SD}	$T_J = 25$ °C	$T_J = 25 ^{\circ}\text{C}, I_S = 6.2 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	2.0	V	
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 9.0 A, dI/dt = 100 A/μs ^b		-	230	350	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			-	1.7	2.6	μC	
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and $L_{\bar L}$				_D)		

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 $\mu s;$ duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

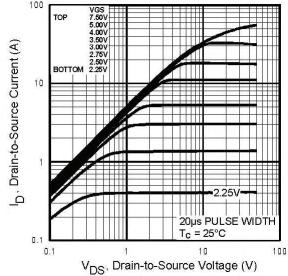


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

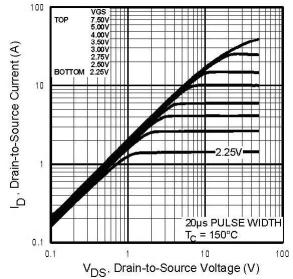


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

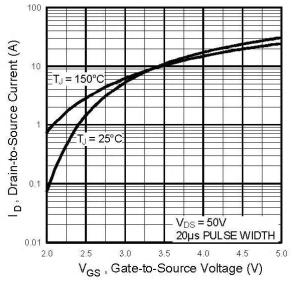


Fig. 3 - Typical Transfer Characteristics

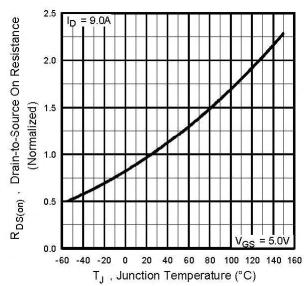


Fig. 4 - Normalized On-Resistance vs. Temperature

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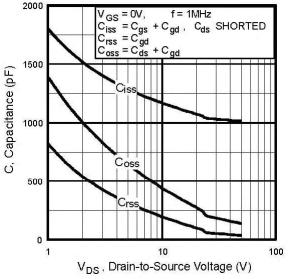


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

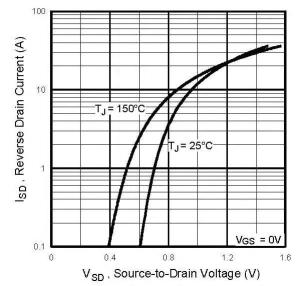


Fig. 7 - Typical Source-Drain Diode Forward Voltage

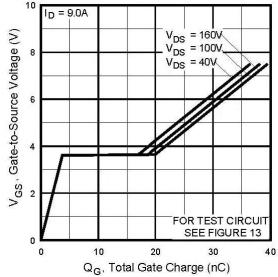


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

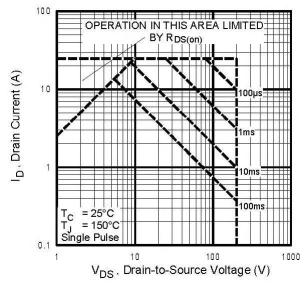


Fig. 8 - Maximum Safe Operating Area



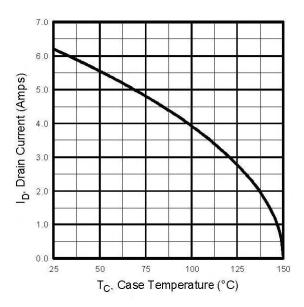


Fig. 9 - Maximum Drain Current vs. Case Temperature

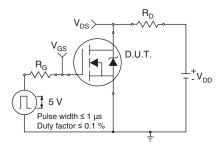


Fig. 10a - Switching Time Test Circuit

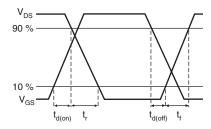


Fig. 10b - Switching Time Waveforms

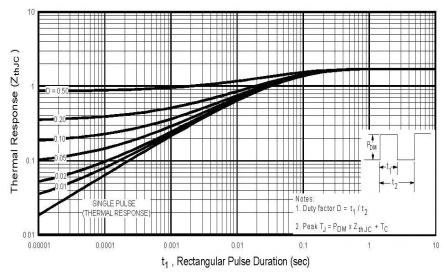


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

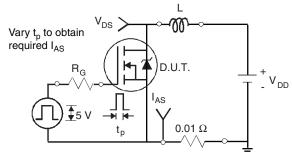


Fig. 12a - Unclamped Inductive Test Circuit

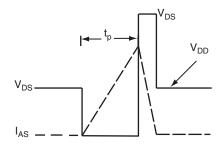


Fig. 12b - Unclamped Inductive Waveforms

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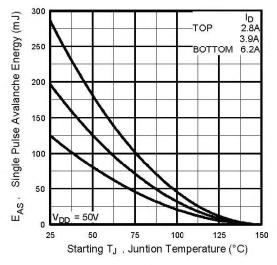


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

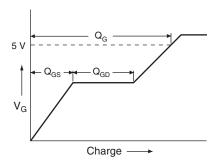


Fig. 13a - Basic Gate Charge Waveform

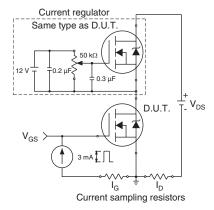
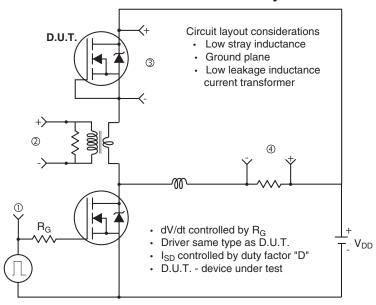
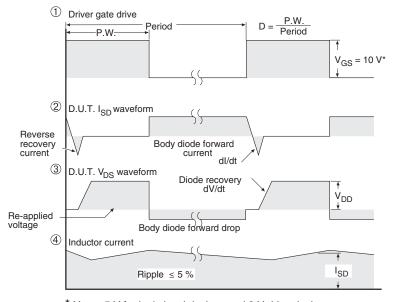


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit





 * V_{GS} = 5 V for logic level devices and 3 V drive devices

Fig. 14 - For N-Channel

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